

# IRF7488PbF

HEXFET® Power MOSFET

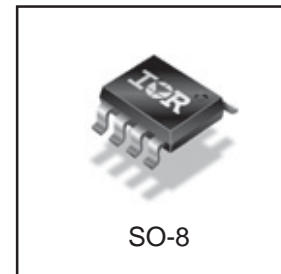
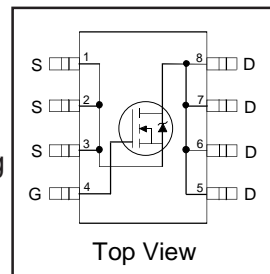
## Applications

- High frequency DC-DC converters
- Lead-Free

|                        |                                |                      |
|------------------------|--------------------------------|----------------------|
| <b>V<sub>DSS</sub></b> | <b>R<sub>DS(on)</sub> max</b>  | <b>Q<sub>g</sub></b> |
| <b>80V</b>             | <b>29mΩ@V<sub>GS</sub>=10V</b> | <b>38nC</b>          |

## Benefits

- Low Gate-to-Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective C<sub>OSS</sub> to Simplify Design, (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current



## Absolute Maximum Ratings

| Symbol                                 | Parameter  | Max.                   | Units |
|--|--|------------------------|-------|
| V <sub>DS</sub>                        | Drain-Source Voltage                             | 80                     | V     |
| V <sub>GS</sub>                        | Gate-to-Source Voltage                           | ± 20                   |       |
| I <sub>D</sub> @ T <sub>A</sub> = 25°C | Continuous Drain Current, V <sub>GS</sub> @ 10V  | 6.3                    | A     |
| I <sub>D</sub> @ T <sub>A</sub> = 70°C | Continuous Drain Current, V <sub>GS</sub> @ 10V  | 5.0                    |       |
| I <sub>DM</sub>                        | Pulsed Drain Current <sup>①</sup>                | 50                     |       |
| P <sub>D</sub> @ T <sub>A</sub> = 25°C | Maximum Power Dissipation                        | 2.5                    | W     |
| P <sub>D</sub> @ T <sub>A</sub> = 70°C | Maximum Power Dissipation                        | 1.6                    |       |
|  | Linear Derating Factor                           | 20                     | mW/°C |
| T <sub>J</sub>                         | Operating Junction and Storage Temperature Range | -55 to + 150           | °C    |
| T <sub>STG</sub>                       | Soldering Temperature, for 10 seconds            | 300 (1.6mm from case ) |       |

## Thermal Resistance

| Symbol           | Parameter                        | Typ. | Max. | Units |
|------------------|----------------------------------|------|------|-------|
| R <sub>θJL</sub> | Junction-to-Drain Lead           | —    | 20   | °C/W  |
| R <sub>θJA</sub> | Junction-to-Ambient <sup>④</sup> | —    | 50   |       |

Notes <sup>①</sup> through <sup>④</sup> are on page 9  
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# IRF7488PbF

International  
IR Rectifier

## Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

|  | Parameter                            | Min. | Typ.  | Max. | Units | Conditions  |
|--|--------------------------------------|------|-------|------|-------|---|
| V <sub>(BR)DSS</sub>                   | Drain-to-Source Breakdown Voltage    | 80   | —     | —    | V     | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA                        |
| ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub> | Breakdown Voltage Temp. Coefficient  | —    | 0.089 | —    | V/°C  | Reference to 25°C, I <sub>D</sub> = 1mA ③                           |
| R <sub>DS(on)</sub>                    | Static Drain-to-Source On-Resistance | —    | 24    | 29   | mΩ    | V <sub>GS</sub> = 10V, I <sub>D</sub> = 3.8A ③                      |
| V <sub>GS(th)</sub>                    | Gate Threshold Voltage               | 2.0  | —     | 4.0  | V     | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA          |
| I <sub>DSS</sub>                       | Drain-to-Source Leakage Current      | —    | —     | 20   | μA    | V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V                         |
|  |                                      | —    | —     | 250  |       | V <sub>DS</sub> = 64V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C |
| I <sub>GSS</sub>                       | Gate-to-Source Forward Leakage       | —    | —     | 200  | nA    | V <sub>GS</sub> = 20V   |
|  | Gate-to-Source Reverse Leakage       | —    | —     | -200 |       | V <sub>GS</sub> = -20V  |

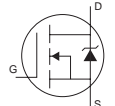
## Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

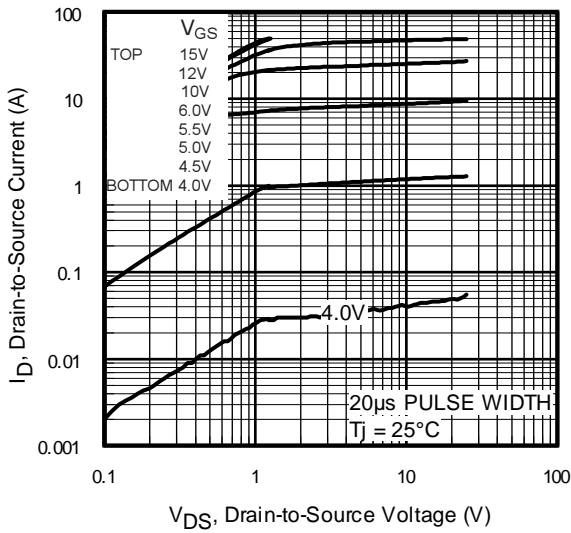
|                       | Parameter                       | Min. | Typ. | Max. | Units | Conditions   |
|-----------------------|---------------------------------|------|------|------|-------|--|
| g <sub>fs</sub>       | Forward Transconductance        | 9.3  | —    | —    | S     | V <sub>DS</sub> = 15V, I <sub>D</sub> = 3.8A             |
| Q <sub>g</sub>        | Total Gate Charge               | —    | 38   | 57   | nC    | I <sub>D</sub> = 3.8A                                    |
| Q <sub>gs</sub>       | Gate-to-Source Charge           | —    | 9.1  | —    |       | V <sub>DS</sub> = 40V                                    |
| Q <sub>gd</sub>       | Gate-to-Drain ("Miller") Charge | —    | 12   | —    |       | V <sub>GS</sub> = 10V,                                   |
| t <sub>d(on)</sub>    | Turn-On Delay Time              | —    | 13   | —    | ns    | V <sub>DD</sub> = 40V                                    |
| t <sub>r</sub>        | Rise Time                       | —    | 12   | —    |       | I <sub>D</sub> = 3.8A                                    |
| t <sub>d(off)</sub>   | Turn-Off Delay Time             | —    | 44   | —    |       | R <sub>G</sub> = 9.1Ω                                    |
| t <sub>f</sub>        | Fall Time                       | —    | 16   | —    |       | V <sub>GS</sub> = 10V ③                                  |
| C <sub>iss</sub>      | Input Capacitance               | —    | 1680 | —    | pF    | V <sub>GS</sub> = 0V                                     |
| C <sub>oss</sub>      | Output Capacitance              | —    | 270  | —    |       | V <sub>DS</sub> = 25V                                    |
| C <sub>riss</sub>     | Reverse Transfer Capacitance    | —    | 32   | —    |       | f = 1.0MHz   |
| C <sub>oss</sub>      | Output Capacitance              | —    | 1760 | —    |       | V <sub>GS</sub> = 0V, V <sub>DS</sub> = 1.0V, f = 1.0MHz |
| C <sub>oss</sub>      | Output Capacitance              | —    | 170  | —    |       | V <sub>GS</sub> = 0V, V <sub>DS</sub> = 64V, f = 1.0MHz  |
| C <sub>oss eff.</sub> | Effective Output Capacitance    | —    | 340  | —    |       | V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 64V ⑤      |

## Avalanche Characteristics

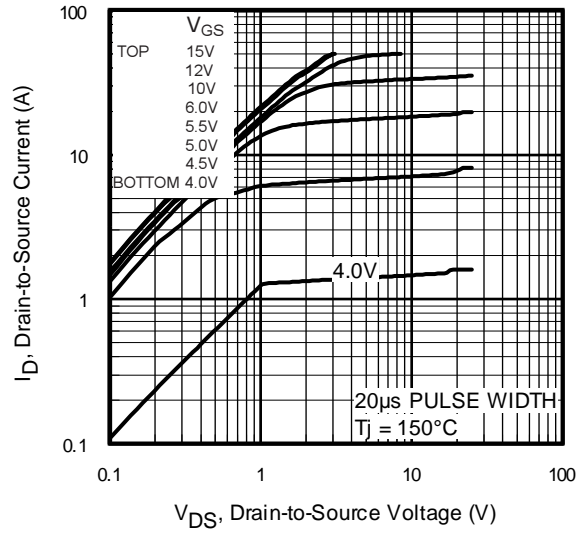
|                 | Parameter                      | Typ. | Max. | Units |
|-----------------|--------------------------------|------|------|-------|
| E <sub>AS</sub> | Single Pulse Avalanche Energy② | —    | 96   | mJ    |
| I <sub>AR</sub> | Avalanche Current①             | —    | 3.8  | A     |

## Diode Characteristics

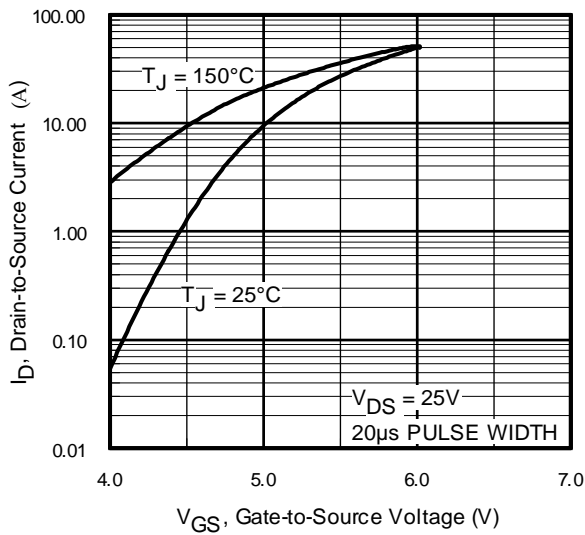
|                 | Parameter                                 | Min. | Typ. | Max. | Units | Conditions   |
|-----------------|---|------|------|------|-------|--|
| I <sub>S</sub>  | Continuous Source Current<br>(Body Diode) | —    | —    | 2.3  | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I <sub>SM</sub> | Pulsed Source Current<br>(Body Diode) ①   | —    | —    | 50   |       |  |
| V <sub>SD</sub> | Diode Forward Voltage                     | —    | —    | 1.3  | V     | T <sub>J</sub> = 25°C, I <sub>S</sub> = 3.8A, V <sub>GS</sub> = 0V ③   |
| t <sub>rr</sub> | Reverse Recovery Time                     | —    | 65   | 98   | ns    | T <sub>J</sub> = 25°C, I <sub>F</sub> = 3.8A   |
| Q <sub>rr</sub> | Reverse Recovery Charge                   | —    | 190  | 290  | nC    | di/dt = 100A/μs ③  |



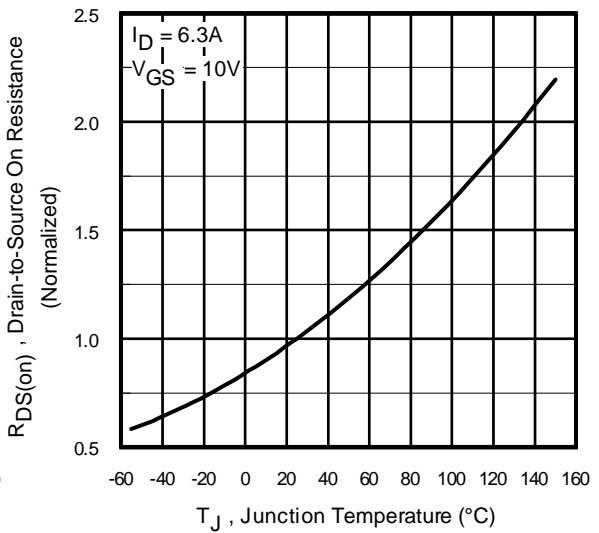
**Fig 1.** Typical Output Characteristics



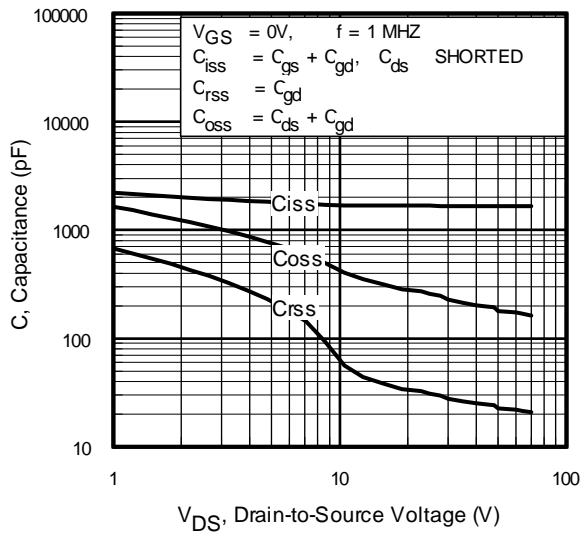
**Fig 2.** Typical Output Characteristics



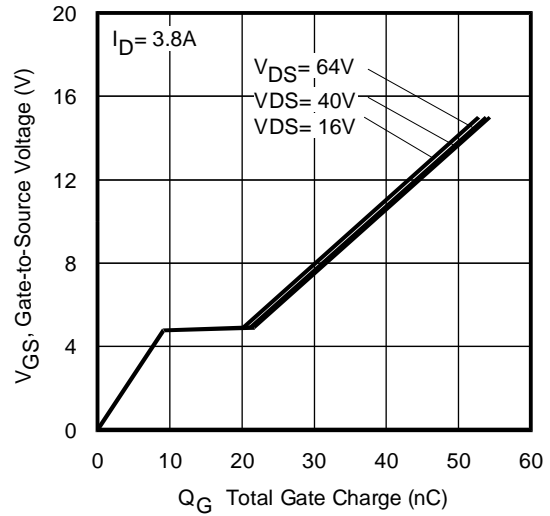
**Fig 3.** Typical Transfer Characteristics



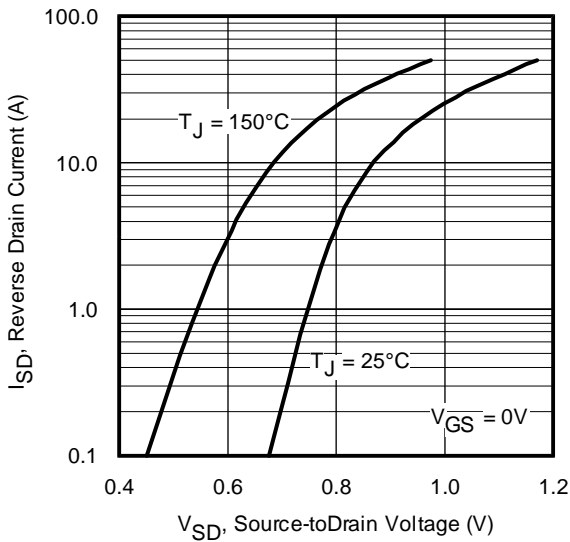
**Fig 4.** Normalized On-Resistance Vs. Temperature



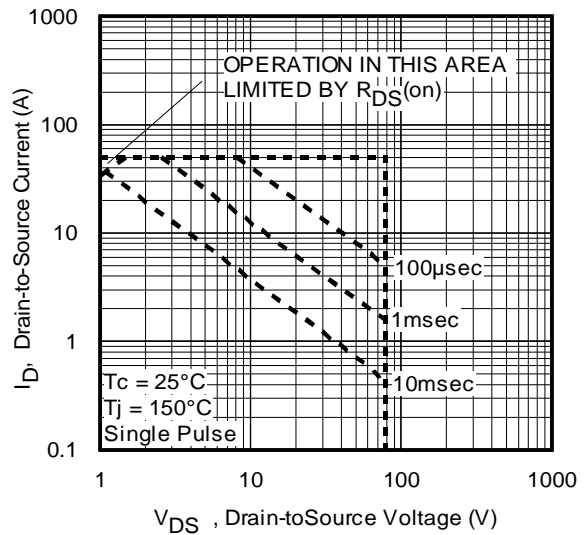
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



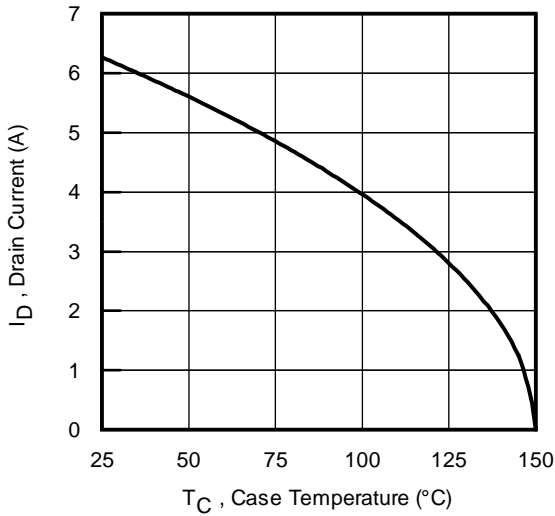
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



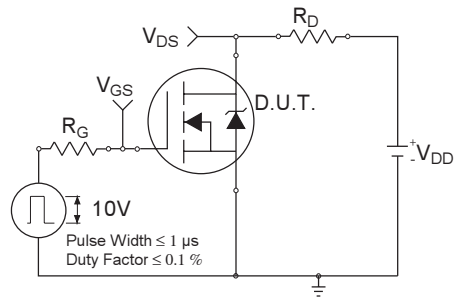
**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 8.** Maximum Safe Operating Area



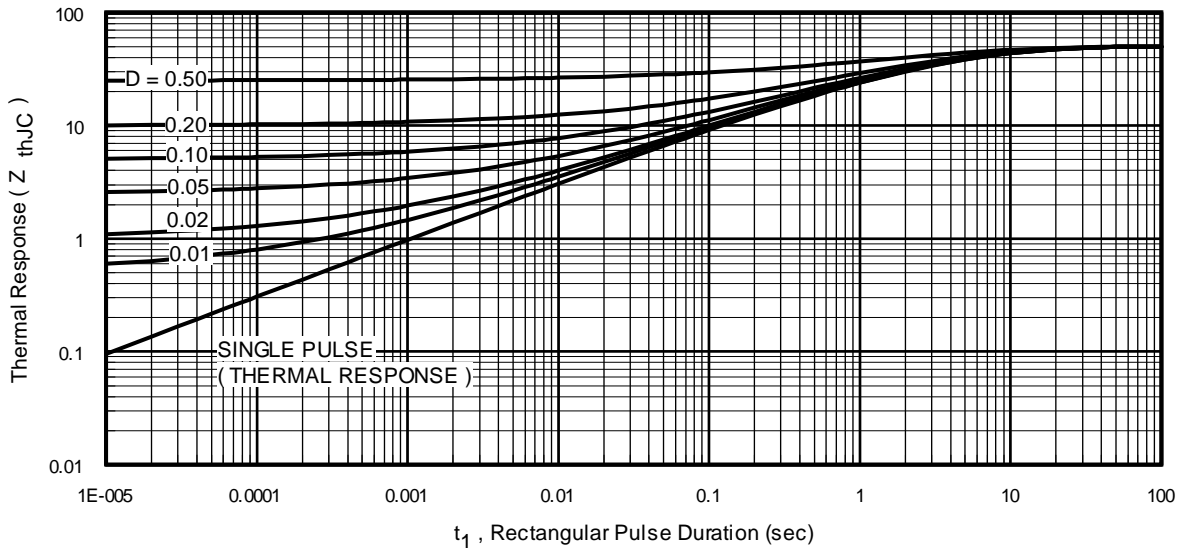
**Fig 9.** Maximum Drain Current Vs. Ambient Temperature



**Fig 10a.** Switching Time Test Circuit



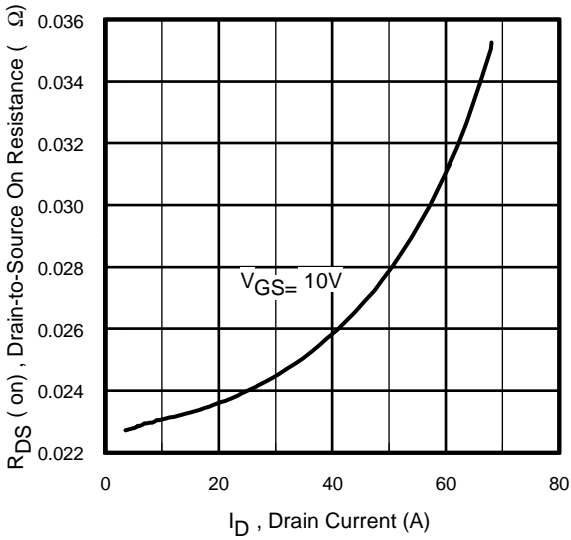
**Fig 10b.** Switching Time Waveforms



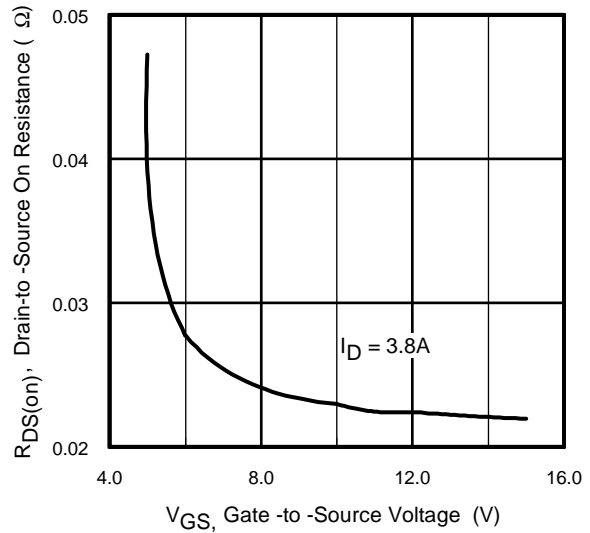
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

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**Fig 12.** On-Resistance Vs. Drain Current



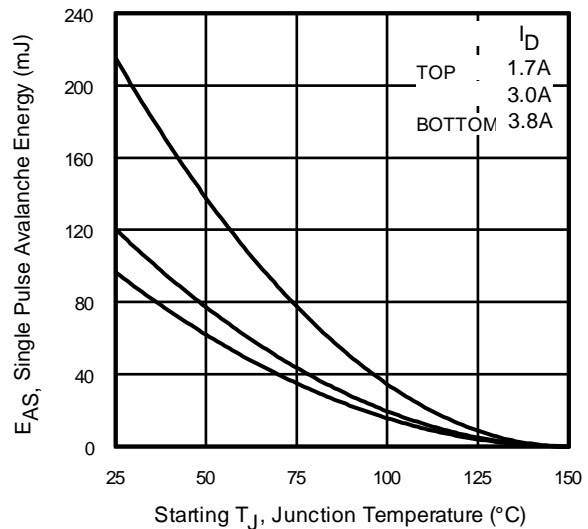
**Fig 13.** On-Resistance Vs. Gate Voltage



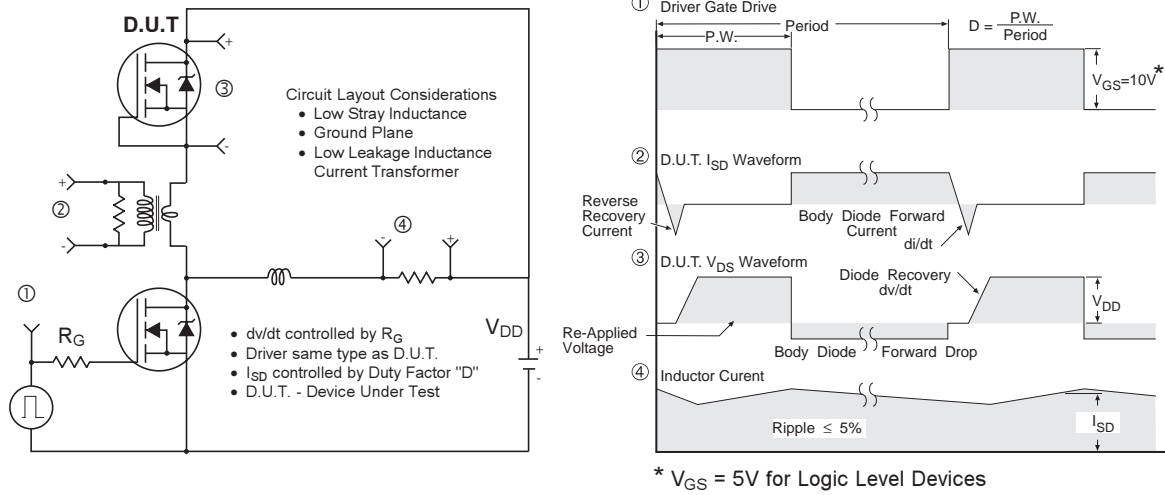
**Fig 14a&b.** Basic Gate Charge Test Circuit and Waveform



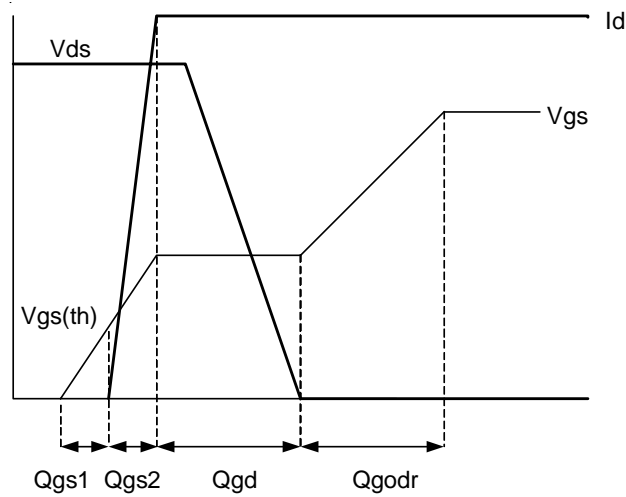
**Fig 15a&b.** Unclamped Inductive Test circuit and Waveforms



**Fig 15c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 16. Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs**



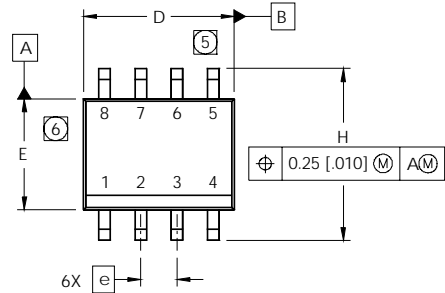
**Fig 17. Gate Charge Waveform**

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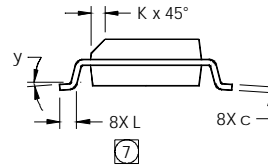
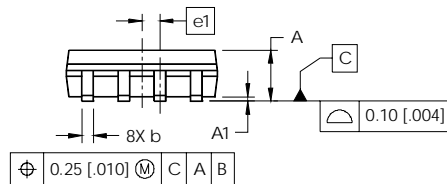
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## SO-8 Package Outline

Dimensions are shown in millimeters (inches)



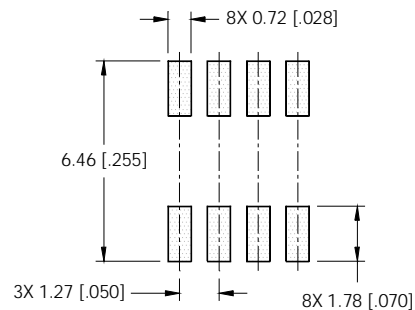
| DIM | INCHES     |       | MILLIMETERS |      |
|-----|------------|-------|-------------|------|
|     | MIN        | MAX   | MIN         | MAX  |
| A   | .0532      | .0688 | 1.35        | 1.75 |
| A1  | .0040      | .0098 | 0.10        | 0.25 |
| b   | .013       | .020  | 0.33        | 0.51 |
| c   | .0075      | .0098 | 0.19        | 0.25 |
| D   | .189       | .1968 | 4.80        | 5.00 |
| E   | .1497      | .1574 | 3.80        | 4.00 |
| e   | .050 BASIC |       | 1.27 BASIC  |      |
| e1  | .025 BASIC |       | 0.635 BASIC |      |
| H   | .2284      | .2440 | 5.80        | 6.20 |
| K   | .0099      | .0196 | 0.25        | 0.50 |
| L   | .016       | .050  | 0.40        | 1.27 |
| y   | 0°         | 8°    | 0°          | 8°   |



### NOTES:

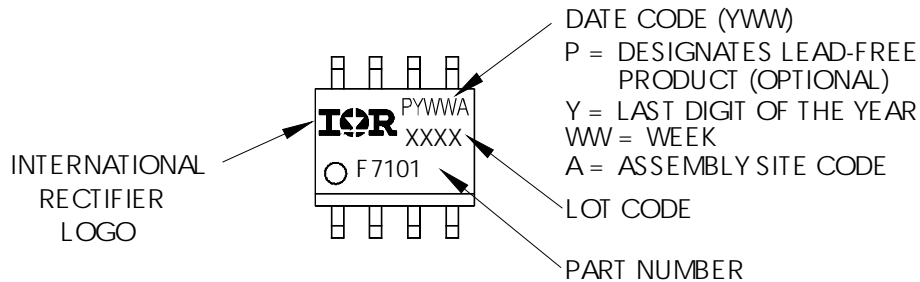
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 [0.006].
6. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 [0.010].
7. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

### FOOTPRINT



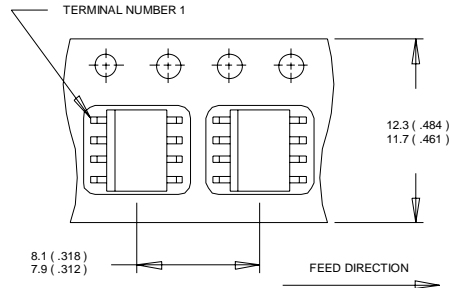
## SO-8 Part Marking

EXAMPLE: THIS IS AN IRF7101 (MOSFET)

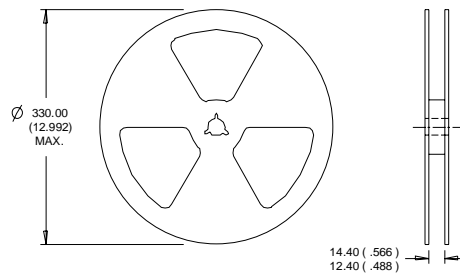




## SO-8 Tape and Reel



- NOTES:  
 1. CONTROLLING DIMENSION : MILLIMETER.  
 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).  
 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES :  
 1. CONTROLLING DIMENSION : MILLIMETER.  
 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

**Notes:**

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 13\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 3.8\text{A}$ .
- ③ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④ When mounted on 1 inch square copper board
- ⑤  $C_{OSS}$  eff. is a fixed capacitance that gives the same charging time as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Consumer market.  
 Qualifications Standards can be found on IR's Web site.